

Search Notes

Application/Control No.

10/772,324

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

LU, WEN-CHIEH

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
135	15.1 16 910	9/23/2005	WSY
362	102 103	9/23/2005	WSY
↓	234 800	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Searched in EAST	9/23/2005	WSY